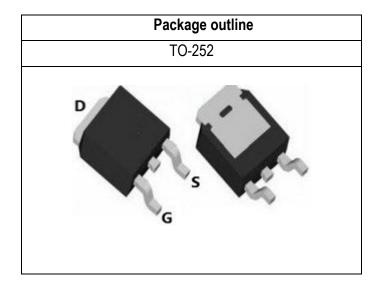


-30V P Channel Enhanced Mode MOSFET

Key parameter	Value	Unit
V(BR)DSS min.	-30	V
RDS(ON) max. VGS=-10V	12.4	mΩ
RDS(ON) max. VGS=-4.5V	22.1	mΩ
I _D	-64.1	Α
V _{GS(TH)} Typ.	-1.5	V
Ciss Typ.	2546	pF
Qg 10V Typ.	43.8	nC



Description

These devices used advanced trench technology of MOSFET to provide excellent electrical parameter. There is high speed switching capability, low RDSON resistance, stabilizing qualitied and characteristics for these devices. Moreover, it is had extreme high cell density in design. These features combine to be an advantage design for use in wide variety of application including small signal control and load switch application.

1

Features

- Fast switch capacity
- ♦ Low R_{DS(ON)} resistance
- Low input capacitance
- With driving logic signal voltage level characteristics
- Pb-free lead plating; RoHS compliant

Symbol and Pin assignment
Pin 2 D S Pin 3

Potential application

- Load Switch
- Motor Driving
- O Power Tools
- ODC to DC Convertor
- High Speed Switch Control

Order Information

	Item	Description
1.	Order Code	SGP3011D
2.	Part Number	SGP3011D
3.	Package Type	TO-252
4.	Package Code	D
5.	Packing Type	Tape & Reel
6.	Quantity in Pack	2,500
7.	RoHS Status	Halogen-Free



-30V P Channel Enhanced Mode MOSFET

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3.	Electrical Characteristics	4
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-30V P Channel Enhanced Mode MOSFET

1. Absolute Maximum Ratings (T_J=25°C unless otherwise noted)

Para	meter	Symbol	Value	Unit
Drain-Source Voltage	V _{DS}	-30	V	
Gate-Source Voltage	V _{GS}	±20	V	
Drain Current-Continuous Note 1	T _C =25°C	1-	-64.1	Α
Diam Current-Continuous Note	T _C =100°C	I _D	-40.5	Α
Drain Current Continuous Note 2	T _A =25°C	1-	-10.2	Α
Drain Current-Continuous Note 2	T _A =70°C	I _D	-8.19	Α
Drain Current-Pulsed Note 3	T _A =25°C	I _{DM}	-130	Α
Avalanche Current		I AR	-26.7	Α
Single Pulse Avalanche Energy Note	4	EAS	35.6	mJ
	T _C =25°C		74.4	W
	T _C =100°C		29.7	W
Maximum Power Dissipation	T _A =25°C	P_D	1.90	W
	T _A =70°C		1.21	W
	Derate Factor Above TC=25°C		0.59	W/°C
Max. Operating Junction Temperate	TJ	150	°C	
Operating and Storage Temperatur	e Range	TJ, TSTG	-55 to 150	°C

2. Thermal Resistance Ratings

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Thermal resistance, Junction-Case	<i>R</i> ө <i>J</i> С-Р	Please refer to Note 5	-	-	1.68	°C/W
Thermal resistance, Junction-Ambient	R өja-p	Please refer to Note 5	-	-	65.74	°C/W

Notes:

- 1. Limited by silicon chip capability and $R_{\Theta JC-P}$ junction-to-case thermal resistance.
- 2. The maximum current rating is limited by package and R_{OJA-P} junction-to-ambient thermal resistance.
- 3. Must be ensure junction temperature does not exceed 150-degree C. (Pulse Width≤380uS, Duty≤2%)
- 4. Limited by T_{Jmax} , starting $T_{J}=25$ °C, L=0.1mH, $R_{g}=25\Omega$, $I_{D}=-26.7A$, $V_{GS}=-10V$.
- 5. The value of thermal resistance is measured with the single device put on cooling plate under a still air environment temperature is 25 degree C based on JEDEC standard JESD51-14 and JESD51-2a. Thermal resistance obtained depends on the user's specific board design and given application.



-30V P Channel Enhanced Mode MOSFET

3. Electrical Characteristics (T_J=25°C unless otherwise noted)

STATIC CHARACTERISTICS		•				
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} =0V, I _{DS} =-250µA	-30	-	-	V
Zoro Cata Valtago Drain Current	1	V _{DS} =-24V, V _{GS} =0V	-	-	-1	μΑ
Zero Gate Voltage Drain Current	IDSS	V _{DS} =-24V, V _{GS} =0V, T _J =125°C	-	-	-10	μΑ
Gate-Body Leakage	Igss	$V_{GS}=\pm20V$, $V_{DS}=0V$	ī	-	±100	nA

STATIC CHARACTERISTICS						
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Gate Threshold Voltage	V _{GS(TH)}	V _{DS} =V _{GS} , I _{DS} =-250µA	-1.2	-1.5	-2.5	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =-10V, I _{DS} =-20.0A	-	10.8	12.4	mΩ
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =-4.5V, I _{DS} =-10.0A	-	17.2	22.1	mΩ
Gate Resistance	R_g	V _{GS} =0V, V _{DS} =0V, f=1MHz	-	7.9	-	Ω
Forward Transconductance	G fs	V _{DS} =-5V, I _{DS} =-16A	-	22	-	S

DYNAMIC CHARACTERISTICS						
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Input Capacitance	Ciss	V _{DD} =-30V, V _{DS} =-15V, V _{GS} =0V, F=1MHz	-	2546	-	pF
Output Capacitance	Coss	V _{DD} =-30V, V _{DS} =-15V, V _{GS} =0V, F=1MHz	-	283	-	pF
Reverse Transfer Capacitance	Crss	V _{DD} =-30V, V _{DS} =-15V, V _{GS} =0V, F=1MHz	-	216	-	pF
Turn-On Delay Time	T _{d(on)}	V _{DS} =-15V, V _{GS} =-10V, I _{DS} =-15A, R _{GEN} =10Ω	-	8.6	-	nS
Rise Time	Tr	V_{DS} =-15V, V_{GS} =-10V, I_{DS} =-15A, R_{GEN} =10 Ω	-	54.0	-	nS
Turn-Off Delay Time	T _{d(off)}	V _{DS} =-15V, V _{GS} =-10V, I _{DS} =-15A, R _{GEN} =10Ω	-	109.4	-	nS
Fall Time	Tf	V_{DS} =-15V, V_{GS} =-10V, I_{DS} =-15A, R_{GEN} =10 Ω	-	72.2	-	nS

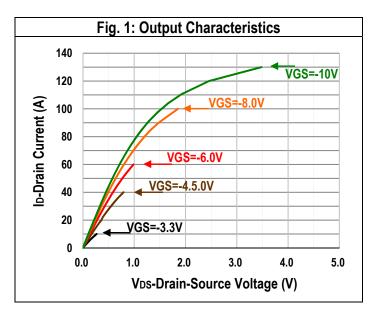
GATE CHARGE CHARACTERISTICS						
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Gate to Source Gate Charge	Q _{gs}	V _{DD} =-15V, I _D =-15A, V _{GS} =0 to -10V	-	9.3	-	nC
Gate charge at threshold	Q _{g(th)}	V _{DD} =-15V, I _D =-15A, V _{GS} =0 to -10V	-	4.0	-	nC
Gate to Drain Charge	Q_{gd}	V _{DD} =-15V, I _D =-15A, V _{GS} =0 to -10V	-	7.3	-	nC
Switching charge	Qsw	V _{DD} =-15V, I _D =-15A, V _{GS} =0 to -10V	-	12.6	-	nC
Gate charge total	Q _g 10V	V _{DD} =-15V, I _D =-15A, V _{GS} =0 to -10V	-	43.8	-	nC
Gate charge total	Qg 4.5V	V _{DD} =-15V, I _D =-15A, V _{GS} =0 to -4.5V	-	20.6	-	nC
Gate plateau voltage	V _{plateau}	V _{DD} =-15V, I _D =-15A, V _{GS} =0 to -10V	-	3.4	-	V
Gate charge total, sync. FET (Q _g - Q _{gd})	Qg(sync)	V _{DS} =-0.1V, V _{GS} =0 to -10V	-	36.5	-	nC

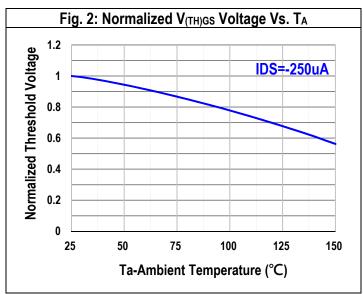
DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS						
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Body Diode continuous forward current	Is	T _C =25°C	-	-	-64.1	Α
Body Diode pulse current	I _{SM}	T _C =25°C	-	-	-130	Α
Body Diode Forward Voltage	V _{SD}	V _{GS} =0V, I _S =-15A	-	-0.88	-1.0	V
Body Diode Reverse Recovery Time	t _{rr}	V _{DD} =-15V, I _F =-15A, di/dt=100A/µs	-	17.0	-	nS
Body Diode Reverse Recovery Charge	Qrr	V _{DD} =-15V, I _F =-15A, di/dt=100A/µs	-	8.32	-	nC
Body Diode Reverse Recovery Current	I _{rm}	V _{DD} =-15V, I _F =-15A, di/dt=100A/µs	-	-0.88	-	Α

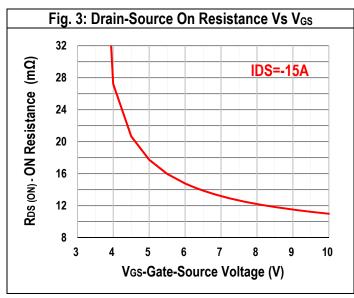


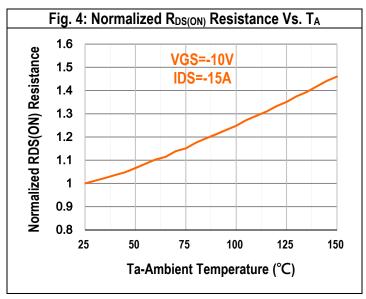
-30V P Channel Enhanced Mode MOSFET

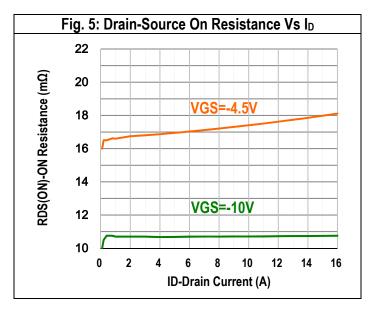
4. Typical Operating Characteristics Diagram

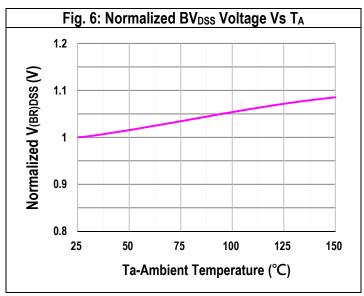








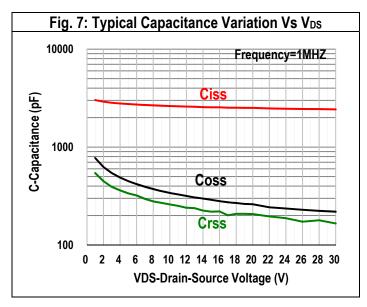


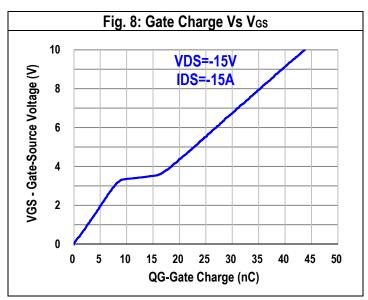


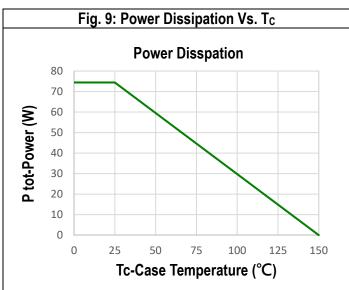


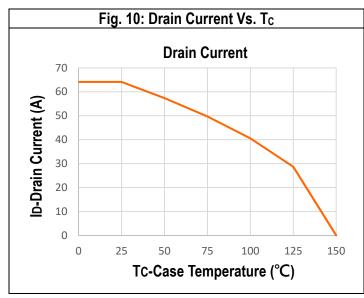
-30V P Channel Enhanced Mode MOSFET

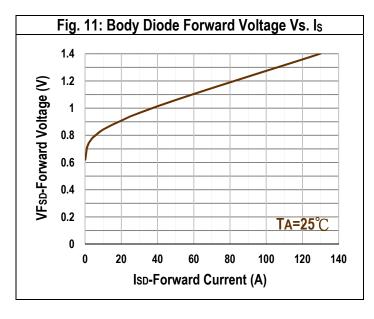
4. Typical Operating Characteristics Diagram

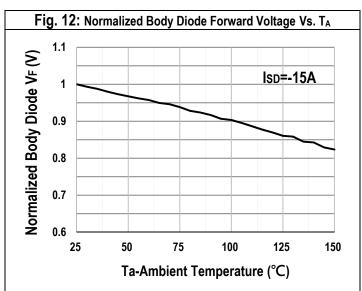








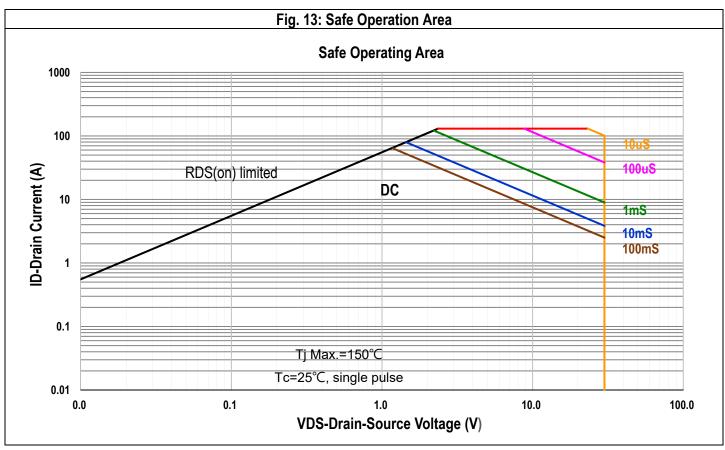


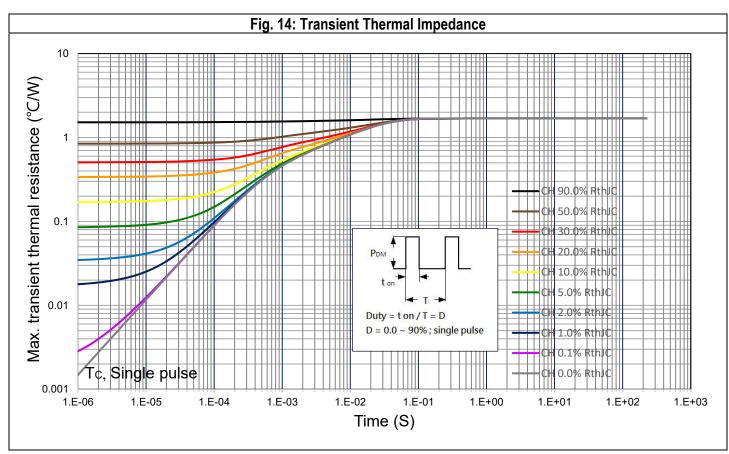






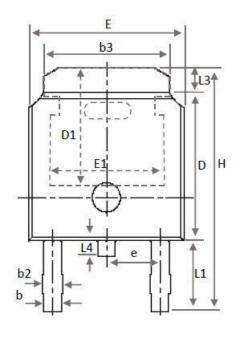
4. Typical Operating Characteristics Diagram

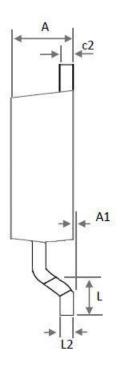




-30V P Channel Enhanced Mode MOSFET

5. Package of Dimension

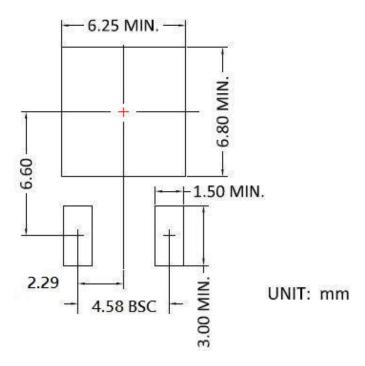




Symbol	Min	Nor	Max		
E	6.35	6.54	6.731		
L	1.40	1.59	1.78		
L1		2.743 Re	f.		
L2	10	0.508 BS	C		
L3	0.89	1.08	1.27		
L4	0.60	0.81	1.01		
D	5.97	6.10	6.223		
Н	9.40	9.91	10.41		
b	0.64	0.77	0.89		
b2	0.76	0.95	1.14		
b3	4.95	5.21	5.46		
е		2.286 BS	C		
Α	2.18	2.29	2.39		
A1	0.00	0.07	0.13		
c2	0.46	0.68	0.89		
D1	5.21	5 9	16		
E1	4.32	3 	10		

- 1. All dimension are in millimeters.
- 2. Dimension does not include burrs and mold flash/protrusions.

6. Land pattern (Footprint)



- Note 1: Land pattern (Footprint) design is for reference only.
- Note 2: Package body sizes exclude mold flash and burrs.
- Note 3: Dimension is measured in gauge plane.
- Note 4: Tolerance 0.1mm unless otherwise specified.

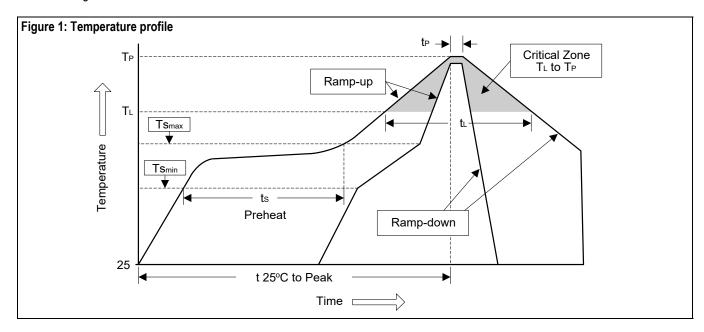


-30V P Channel Enhanced Mode MOSFET

7. Appendix-A

Soldering Methods for Silicongear's Products (Just for SMD type of device)

- 1. Storage environment: Temperature=10°C to 35°C Humidity=65%±15%
- 2. Reflow soldering of surface-mount devices



Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Average ramp-up rate (T _L to T _P)	<3°C/sec	<3°C/sec
Preheat		
- Temperature Min (Ts _{min})	100°C	150°C
- Temperature Max (Ts _{max})	150°C	200°C
- Time (min to max) (ts)	60 to 120 sec	60 to 180 sec
Tsmax to T∟		
- Ramp-up Rate	<3°C/sec	<3°C/sec
Time maintained above:		
- Temperature (T∟)	183°C	217°C
- Time (t∟)	60 to 150 sec	60 to 150 sec
Peak Temperature (T _P)	240°C +0/-5°C	260°C +0/-5°C
Time within 5°C of actual Peak	10 to 20 occ	20 to 40 cos
Temperature (t⊳)	10 to 30 sec	20 to 40 sec
Ramp-down Rate	<6°C/sec	<6°C/sec
Time 25°C to Peak Temperature	<6 minutes	<8 minutes

3. Flow (wave) soldering (solder dipping)

Products	Peak Temperature	Dipping Time
Pb devices.	245°C ±5°C	5sec ±1sec
Pb-Free devices.	260°C +0/-5°C	5sec ±1sec



-30V P Channel Enhanced Mode MOSFET

7. Appendix-B

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